Appl. No. 10/519,175 Amdt. dated June 20, 2008 Amendment Submitted with RCE

Amendments to the Claims:

This listing of claims will replace all prior versions, and listings of claims in the application:

Listing of Claims:

1-17. (canceled)

1 18. (previously presented) A method as in claim 24 wherein step (b) advances 2 curing of the thermosetting resin.

19 and 20. (canceled)

- 1 21. (previously presented) A method as in claim 24 wherein the 2 semiconductor device comprises an integrated circuit.
- 1 22. (previously presented) A method as in claim 24 wherein step (a) includes a 2 transfer molding process.
- 23. (previously presented) A method as in claim 24 wherein step (a) includes a
 potting process.
- 1 24. (Currently amended) A method of making a semiconductor device to be soldered with an Sn-Ag-Cu type solder to a substrate, the method comprising:
- 3 (a) sealing the semiconductor device in a package by surrounding it with
 4 thermosetting resin and thermally curing the resin at a first temperature;
- 5 (b) baking the thermosetting resin at a second temperature not higher than the 6 first temperature;
- 7 (c) further baking the thermosetting resin at a third temperature higher than 8 the first temperature, wherein the third temperature is between about 220°C and about 260°C;

9 and

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(d) inspecting the semiconductor device.

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- 25. (previously presented) A method as in claim 24 wherein a conductive lead
 is adhesively affixed to a main surface of the semiconductor device.
- 1 26. (previously presented) A method as in claim 25 wherein the conductive
- 2 lead is adhesively affixed to a peripheral portion of the main surface of the semiconductor
- 3 device.
- 1 27. (previously presented) A method as in claim 26 wherein an electrode of 2 the semiconductor device is electrically connected to the conductive lead.

28-30. (canceled)